⎍IXYS

HiPerFET™ Power MOSFETs
## Single Die MOSFET

	V_{DSS}	$I_{D\ (cont)}$	$R_{DS(on)}$	t_{rr}
IXFN 26N90	900 V	26 A	0.30 Ω	250 ns
IXFN 25N90	900 V	25 A	0.33 Ω	250 ns

N-Channel Enhancement Mode
Avalanche Rated, High dv/dt, Low t_{rr}

Preliminary data sheet

D
G
S
S
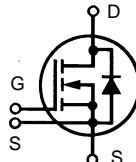
miniBLOC, SOT-227 B (IXFN)
Ⓤ E153432

Symbol	Test Conditions		Maximum Ratings	
V_{DSS}	T_J = 25°C to 150°C		900	V
V_{DGR}	T_J = 25°C to 150°C; R_{GS} = 1 MΩ		900	V
V_{GS}	Continuous		±20	V
V_{GSM}	Transient		±30	V
I_{D25}	T_C = 25°C	26N90	26	A
		25N90	25	
I_{DM}	T_C = 25°C, pulse width limited by T_{JM}	26N90	104	A
		25N90	100	
I_{AR}	T_C = 25°C	26N90	26	A
		25N90	25	
E_{AR}	T_C = 25°C		64	mJ
E_{AS}	T_C = 25°C		3	J
dv/dt	I_S ≤ I_{DM}, di/dt ≤ 100 A/μs, V_{DD} ≤ V_{DSS}, T_J ≤ 150°C, R_G = 2 Ω		5	V/ns
P_D	T_C = 25°C		600	W
T_J			-55 ... +150	°C
T_{JM}			150	°C
T_{stg}			-55 ... +150	°C
T_J	1.6 mm (0.63 in) from case for 10 s		-	°C
V_{ISOL}	50/60 Hz, RMS t = 1 min		2500	V~
	I_{ISOL} ≤ 1 mA t = 1 s		3000	V~
M_d	Mounting torque		1.5/13	Nm/lb.in.
	Terminal connection torque		1.5/13	Nm/lb.in.
Weight			30	g

G = Gate   D = Drain
S = Source

Either Source terminal at miniBLOC can be used as Main or Kelvin Source

Features

- International standard package
- miniBLOC, with Aluminium nitride isolation
- Low $R_{DS\ (on)}$ HDMOS™ process
- Rugged polysilicon gate cell structure
- Unclamped Inductive Switching (UIS) rated
- Low package inductance
- Fast intrinsic Rectifier

Applications

- DC-DC converters
- Battery chargers
- Switched-mode and resonant-mode power supplies
- DC choppers
- Temperature and lighting controls

Advantages

- Easy to mount
- Space savings
- High power density

Symbol	Test Conditions			Characteristic Values (T_J = 25°C, unless otherwise specified)		
				min.	typ.	max.
V_{DSS}	V_{GS} = 0 V, I_D = 3 mA			900		V
$V_{GH(th)}$	V_{DS} = V_{GS}, I_D = 8 mA			3.0		5.0	V
I_{GSS}	V_{GS} = ±20 V_{DC}, V_{DS} = 0					±200	nA
I_{DSS}	V_{DS} = 0.8 • V_{DSS}	T_J = 25°C				100	μA
	V_{GS} = 0 V	T_J = 125°C				2	mA
$R_{DS(on)}$	V_{GS} = 10 V, I_D = 0.5 • I_{D25}	26N90				0.30	Ω
	Pulse test, t ≤ 300 μs, duty cycle d ≤ 2 %	25N90				0.33	Ω

IXYS reserves the right to change limits, test conditions, and dimensions.

Symbol	Test Conditions	Characteristic Values $(T_J = 25°C$, unless otherwise specified)			
		min.	typ.	max.	
g_{fs}	$V_{DS} = 10$ V; $I_D = 0.5 \cdot I_{D25}$, pulse test	18	28		S
C_{iss}			8.7	10.8	nF
C_{oss}	$V_{GS} = 0$ V, $V_{DS} = 25$ V, f = 1 MHz		800	1000	pF
C_{rss}			300	375	pF
$t_{d(on)}$			60		ns
t_r	$V_{GS} = 10$ V, $V_{DS} = 0.5 \cdot V_{DSS}$, $I_D = 0.5 \cdot I_{D25}$		35		ns
$t_{d(off)}$	$R_G = 1\ \Omega$ (External)		130		ns
t_f			24		ns
$Q_{g(on)}$			240		nC
Q_{gs}	$V_{GS} = 10$ V, $V_{DS} = 0.5 \cdot V_{DSS}$, $I_D = 0.5 \cdot I_{D25}$		56		nC
Q_{gd}			107		nC
R_{thJC}				0.21	K/W
R_{thCK}			0.05		K/W

miniBLOC, SOT-227 B
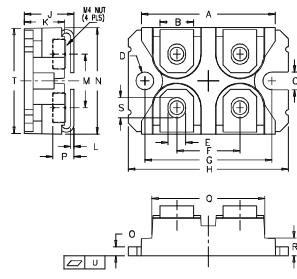
M4 screws (4x) supplied

Dim.	Millimeter Min.	Max.	Inches Min.	Max.
A	31.50	31.88	1.240	1.255
B	7.80	8.20	0.307	0.323
C	4.09	4.29	0.161	0.169
D	4.09	4.29	0.161	0.169
E	4.09	4.29	0.161	0.169
F	14.91	15.11	0.587	0.595
G	30.12	30.30	1.186	1.193
H	38.00	38.23	1.496	1.505
J	11.68	12.22	0.460	0.481
K	8.92	9.60	0.351	0.378
L	0.76	0.84	0.030	0.033
M	12.60	12.85	0.496	0.506
N	25.15	25.42	0.990	1.001
O	1.98	2.13	0.078	0.084
P	4.95	5.97	0.195	0.235
Q	26.54	26.90	1.045	1.059
R	3.94	4.42	0.155	0.174
S	4.72	4.85	0.186	0.191
T	24.59	25.07	0.968	0.987
U	-0.05	0.1	-0.002	0.004

Source-Drain Diode

Symbol	Test Conditions	Characteristic Values $(T_J = 25°C$, unless otherwise specified)			
		min.	typ.	max.	
I_S	$V_{GS} = 0$ V	26N90 25N90		26 25	A
I_{SM}	Repetitive; pulse width limited by T_{JM}	26N90 25N90		104 100	A
V_{SD}	$I_F = I_S$, $V_{GS} = 0$ V, Pulse test, t ≤ 300 μs, duty cycle d ≤ 2 %			1.5	V
t_{rr}	$I_F = I_S$, -di/dt = 100 A/μs, $V_R = 100$ V			250	ns
Q_{RM}			1.4		μC
I_{RM}			10		A

IXYS

Figure 1. Output Characteristics at 25°C
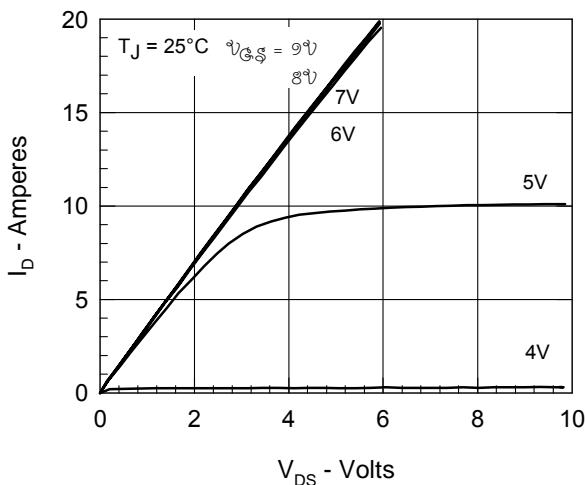
Figure 2. Extended Output Characteristics at 125°C
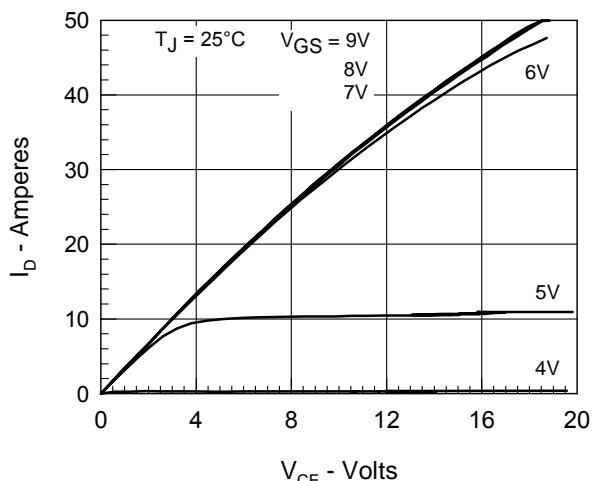
Figure 3. $R_{DS(on)}$ normalized to 0.5 I_{D25} value vs. I_D
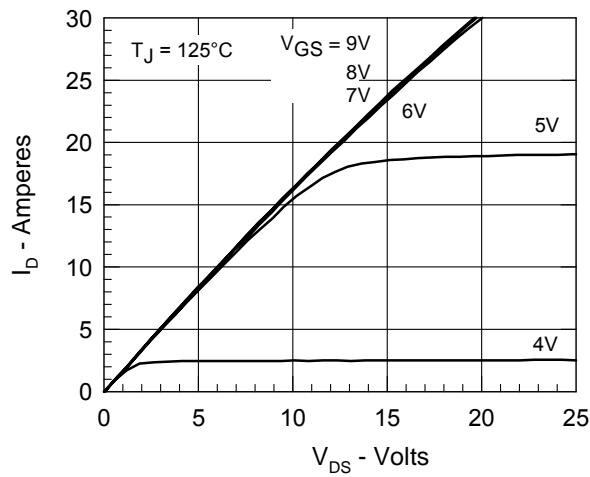

Figure 4. Admittance Curves
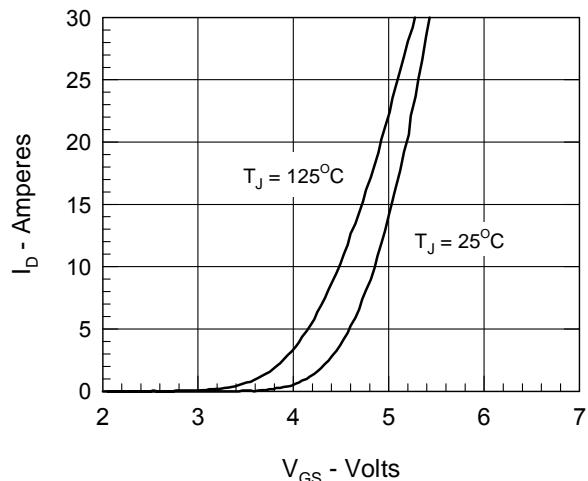
Figure 5. $R_{DS(on)}$ normalized to 0.5 I_{D25} value vs. I_D
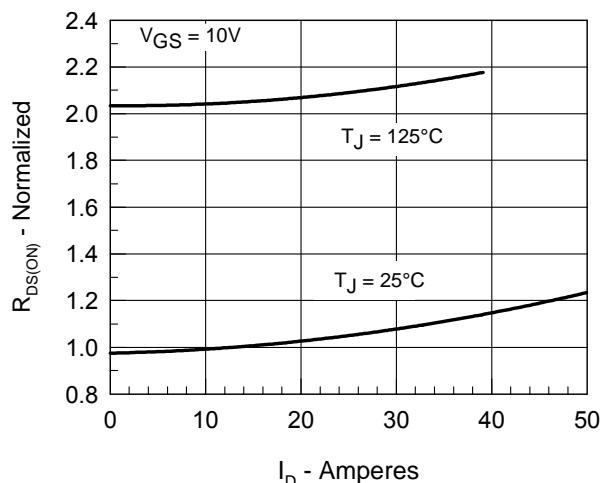
Figure 6. $R_{DS(on)}$ normalized to 0.5 I_{D25} value vs. T_J

Figure 7. Gate Charge

V_{DS} = 500 V
I_D = 13 A
I_G = 10 mA

V_{GS} - Volts
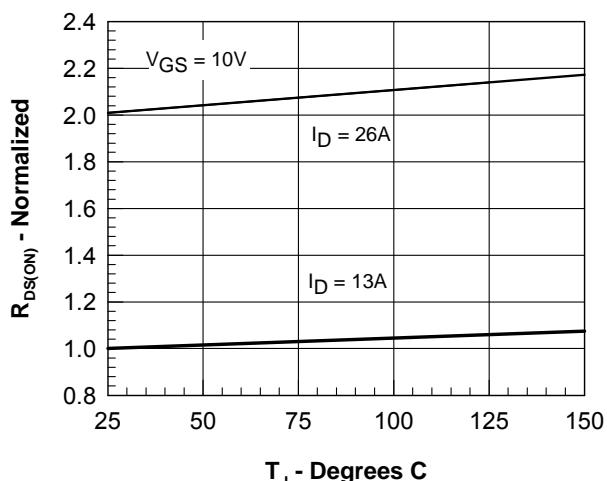
Gate Charge - nC
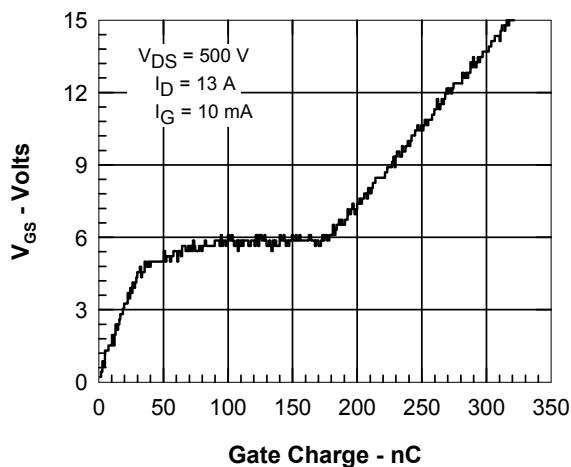
Figure 8. Capacitance Curves

Ciss

Coss

Crss

f = 1MHz

Capacitance - pF

V_{DS} - Volts

Capacitance Curves

T_J = 125°C

T_J = 25°C

I_D - Amperes
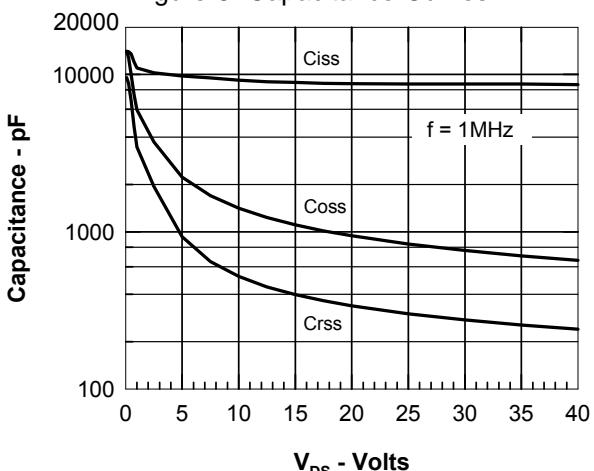
V_{SD} - Volts
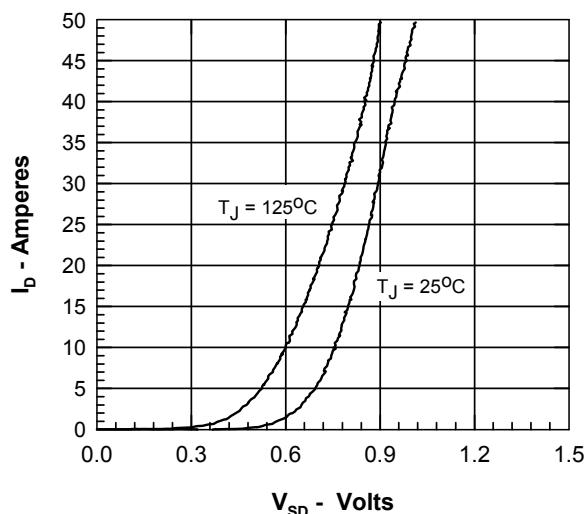
Figure10. Drain Current vs. Case Temperature

IXFN26N90

IXFN25N90

I_D - Amperes

Case Temperatue - °C
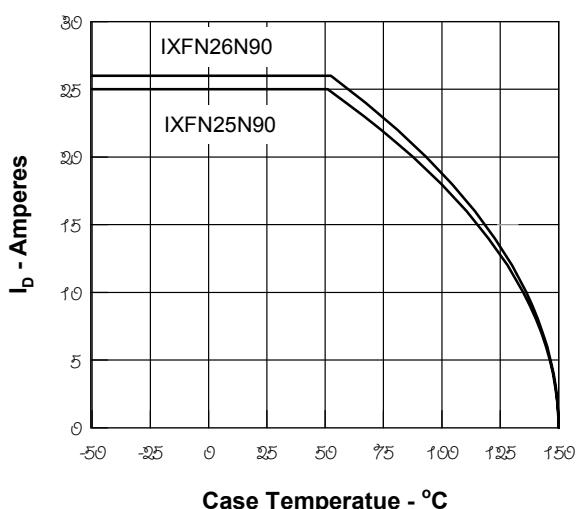
Figure 11. Transient Thermal Resistance

$R(th)_{JC}$ - K/W

Pulse Width - Seconds